Search Notes

Application/Contro	ol No.	Applicant(s)/Patent under Reexamination	
10/614,965		BOEHM ET AL.	
Examiner		Art Unit	
Alan S. Chen		2182	

SEARCHED				
Class	Subclass	Date	Examiner	
710	2	4/25/2005	ASC	
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J	72	J	1	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
(EAST) USPAT; USPGPUB; EPO; JPO; IBM_TDB; DERWENT	4/25/2005	ASC		
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